MOSFET – Power, Single, N-Channel, SO-8FL 30 V, 0.9 mΩ, 303 A

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Current R ₀ JC (Notes 1, 3)	Steady	$T_C = 25^{\circ}C$ I_I		303	Α
Power Dissipation $R_{\theta JC}$ (Notes 1, 3)	State	T _C = 25°C	P _D	134	W
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2, 3)	urrent $R_{\theta JA}$		I _D	47	Α
Power Dissipation $R_{\theta JA}$ (Notes 1, 2, 3)	Oldic	T _A = 25°C	P _D	3.2	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	552	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 150	°C
Source Current (Body Diode)			I _S	110	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 35 A)			E _{AS}	862	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.93	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

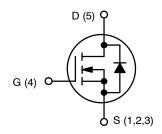
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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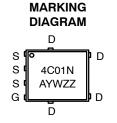
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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	0.9 mΩ @ 10 V	000 4
	1.2 mΩ @ 4.5 V	303 A



N-CHANNEL MOSFET





= Assembly Location Α

= Year W = Work Week = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]			
NTMFS4C01NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel			
NTMFS4C01NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel			

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

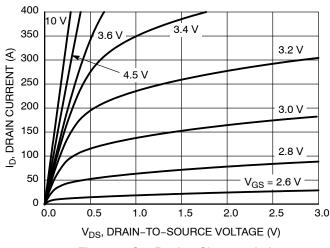
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-			-	<u> </u>		-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				16.3		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25 °C			1	μА
		V _{DS} = 24 V	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{G}$	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.3		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.8		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		0.71	0.9	mΩ
		V _{GS} = 4.5 V	I _D = 30 A		0.94	1.2	
Forward Transconductance	9 _{FS}	V _{DS} = 3 V	I _D = 30 A		183		S
Gate Resistance	R_{G}	T _A = 25 °C			1.0		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			10144		pF
Output Capacitance	Coss				5073		
Reverse Transfer Capacitance	C _{RSS}				148		
Total Gate Charge	Q _{G(TOT)}				63		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			18		nC
Gate-to-Source Charge	Q _{GS}				29		
Gate-to-Drain Charge	Q_{GD}				13		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 30 A			139		nC
SWITCHING CHARACTERISTICS (Note 5)	•	•					•
Turn-On Delay Time	t _{d(ON)}				29		
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_{D} = 15 \text{ A},$ $R_{G} = 3.0 \Omega$			68		- ns
Turn-Off Delay Time	t _{d(OFF)}				53		
Fall Time	t _f				36		
DRAIN-SOURCE DIODE CHARACTERISTIC	s	•					•
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.73	1.1	1 V
		I _S = 10 A	T _J = 125°C		0.55		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			87		ns
Charge Time	ta				43		
Discharge Time	t _b				44		
	Q _{RR}						1

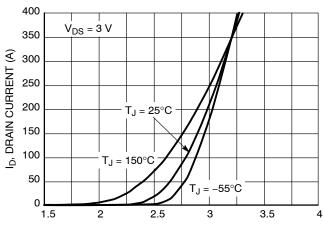
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS





V_{GS}, GATE-TO-SOURCE VOLTAGE (V)



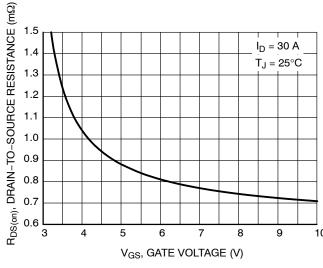


Figure 3. On-Resistance vs. Gate-to-Source Voltage

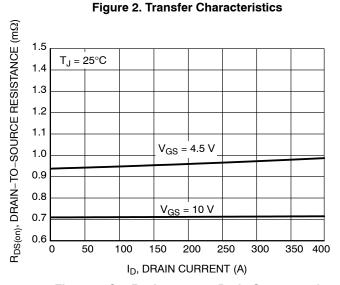


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

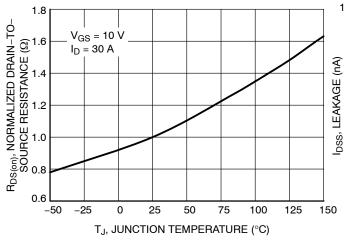


Figure 5. On–Resistance Variation with Temperature

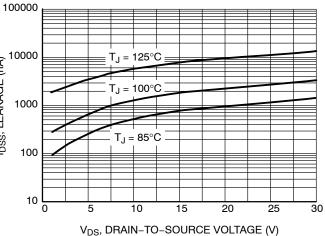


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

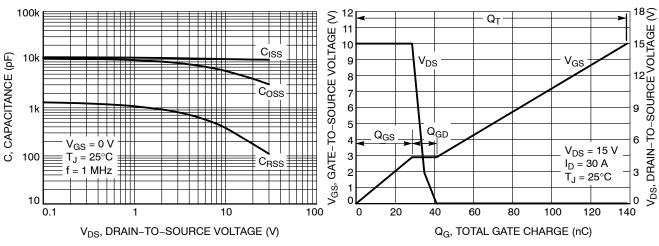


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

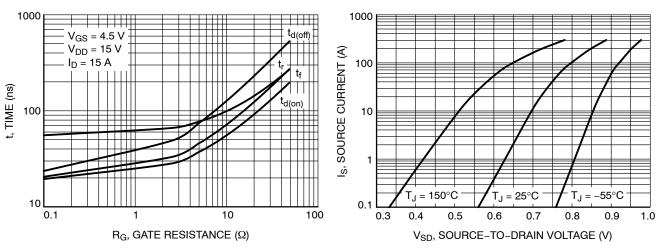


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

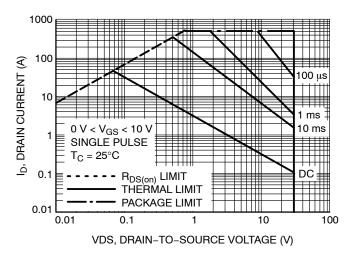


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

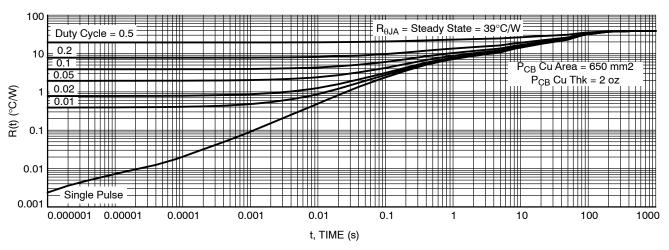


Figure 12. Thermal Impedance (Junction-to-Ambient)

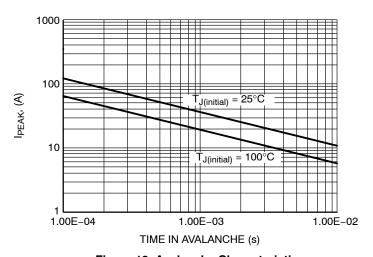
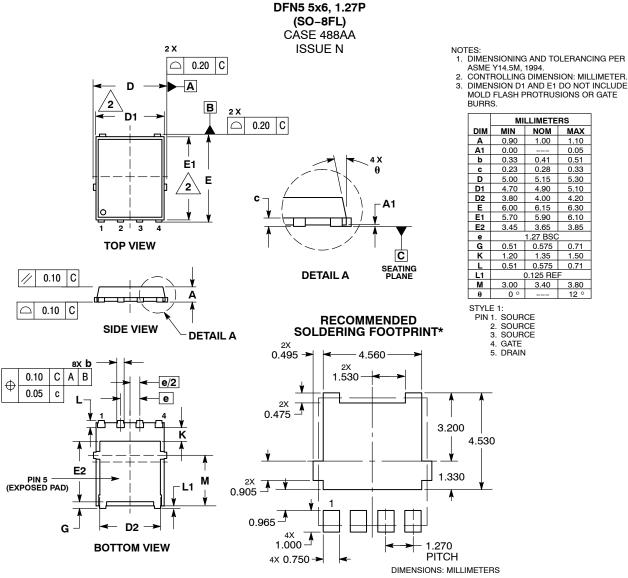


Figure 13. Avalanche Characteristics

PACKAGE DIMENSIONS



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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